

STB95N3LLH6, STD95N3LLH6 STP95N3LLH6, STU95N3LLH6

N-channel 30 V, 0.0037 Ω , 80 A, D²PAK, DPAK, IPAK, TO-220
STripFET™ VI DeepGATE™ Power MOSFET

Features

Type	V _{DSS}	R _{DS(on)} max	I _D
STB95N3LLH6	30 V	0.0042 Ω	80 A
STD95N3LLH6	30 V	0.0042 Ω	80 A
STP95N3LLH6	30 V	0.0042 Ω	80 A
STU95N3LLH6	30 V	0.0047 Ω	80 A

- R_{DS(on)} * Q_g industry benchmark
- Extremely low on-resistance R_{DS(on)}
- High avalanche ruggedness
- Low gate drive power losses

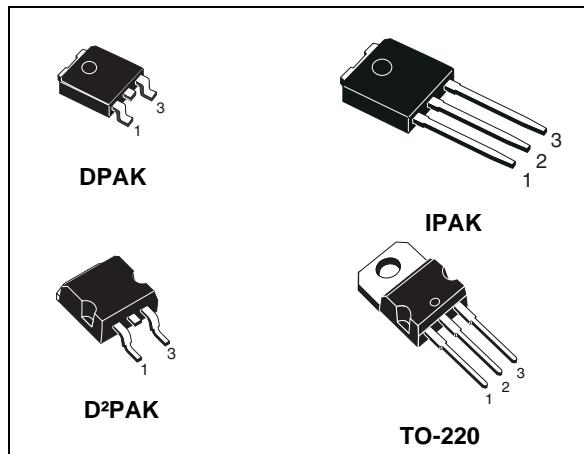


Figure 1. Internal schematic diagram

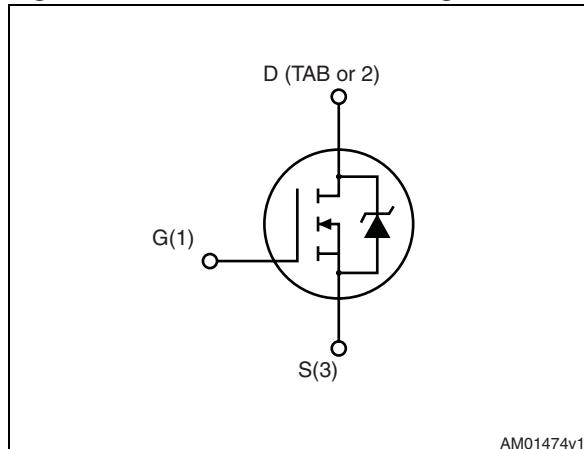


Table 1. Device summary

Order codes	Marking	Package	Packaging
STB95N3LLH6	95N3LLH6	D ² PAK	Tape and reel
STD95N3LLH6	95N3LLH6	DPAK	Tape and reel
STP95N3LLH6	95N3LLH6	TO-220	Tube
STU95N3LLH6	95N3LLH6	IPAK	Tube

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage ($V_{GS} = 0$)	30	V
V_{GS}	Gate-source voltage	± 20	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	80	A
I_D	Drain current (continuous) at $T_C = 100^\circ\text{C}$	61	A
$I_{DM}^{(2)}$	Drain current (pulsed)	320	A
P_{TOT}	Total dissipation at $T_C = 25^\circ\text{C}$	70	W
	Derating factor	0.47	W/ $^\circ\text{C}$
$E_{AS}^{(3)}$	Single pulse avalanche energy	150	mJ
T_{stg}	Storage temperature	-55 to 175	$^\circ\text{C}$
T_j	Max. operating junction temperature	175	$^\circ\text{C}$

1. Limited by wire bonding
2. Pulse width limited by safe operating area
3. Starting $T_j = 25^\circ\text{C}$, $I_{AV} = 55 \text{ A}$, $L = 0.1 \text{ mH}$

Table 3. Thermal data

Symbol	Parameter	Value				Unit
		D ² PAK	DPAK	IPAK	TO-220	
$R_{thj-case}$	Thermal resistance junction-case max	2.14		$^\circ\text{C/W}$		
$R_{thj-amb}$	Thermal resistance junction-ambient max		100		62.5	$^\circ\text{C/W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb max	35	35			$^\circ\text{C/W}$
T_I	Maximum lead temperature for soldering purpose	275		300	$^\circ\text{C}$	

1. When mounted on FR-4 board of 1 inch², 2 oz Cu.

2 Electrical characteristics

($T_{CASE} = 25^\circ\text{C}$ unless otherwise specified)

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0$	30			V
I_{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	$V_{DS} = 30 \text{ V}$ $V_{DS} = 30 \text{ V}, T_c = 125^\circ\text{C}$			1 10	μA μA
I_{GSS}	Gate body leakage current ($V_{DS} = 0$)	$V_{GS} = \pm 20 \text{ V}$			± 100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1		2.5	V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 40 \text{ A}$ SMD version		0.0037	0.0042	Ω
		$V_{GS} = 10 \text{ V}, I_D = 40 \text{ A}$		0.0042	0.0047	Ω
		$V_{GS} = 4.5 \text{ V}, I_D = 40 \text{ A}$ SMD version		0.0055	0.007	Ω
		$V_{GS} = 4.5 \text{ V}, I_D = 40 \text{ A}$		0.006	0.0075	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min	Typ.	Max.	Unit
C_{iss}	Input capacitance			2200		pF
C_{oss}	Output capacitance	$V_{DS} = 25 \text{ V}, f=1 \text{ MHz}$, $V_{GS} = 0$	-	400	-	pF
C_{rss}	Reverse transfer capacitance			280		pF
Q_g	Total gate charge	$V_{DD} = 15 \text{ V}, I_D = 80 \text{ A}$		20		nC
Q_{gs}	Gate-source charge	$V_{GS} = 4.5 \text{ V}$	-	8.2	-	nC
Q_{gd}	Gate-drain charge			7.5		nC
Q_{gs1}	Pre V_{th} gate-to-source charge	$V_{DD} = 15 \text{ V}, I_D = 80 \text{ A}$		3.4		nC
Q_{gs2}	Post V_{th} gate-to-source charge		-	6.2		nC
R_G	Gate input resistance	$f = 1 \text{ MHz}$ gate bias Bias = 0 test signal level = 20 mV open drain	-	1	-	Ω

Table 6. Switching on/off (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r	Turn-on delay time Rise time	$V_{DD} = 15 \text{ V}$, $I_D = 40 \text{ A}$, $R_G = 4.7 \Omega$, $V_{GS} = 5 \text{ V}$	-	19 91	-	ns ns
$t_{d(off)}$ t_f	Turn-off delay time Fall time	$V_{DD} = 15 \text{ V}$, $I_D = 40 \text{ A}$, $R_G = 4.7 \Omega$, $V_{GS} = 5 \text{ V}$	-	24.5 23.4	-	ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD} $I_{SDM}^{(1)}$	Source-drain current Source-drain current (pulsed)		-		80 320	A A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 40 \text{ A}$, $V_{GS} = 0$	-		1.1	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 80 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$, $V_{DD} = 24 \text{ V}$	-	28.6 22.8 1.6		ns nC A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

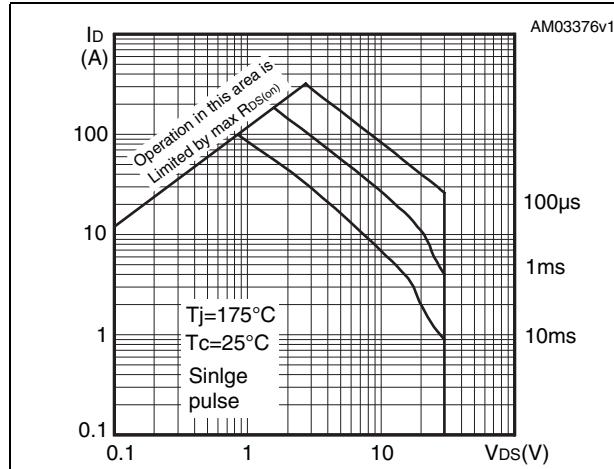


Figure 3. Thermal impedance

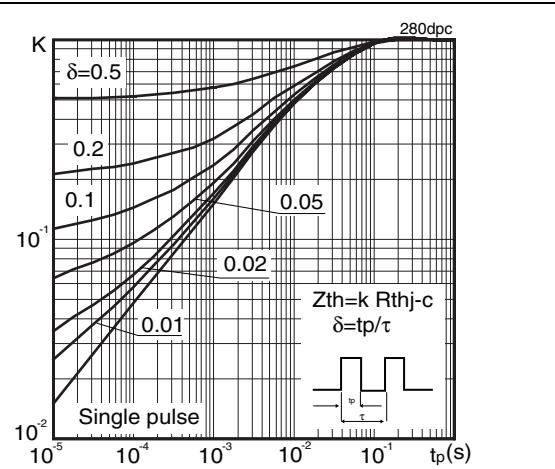


Figure 4. Output characteristics

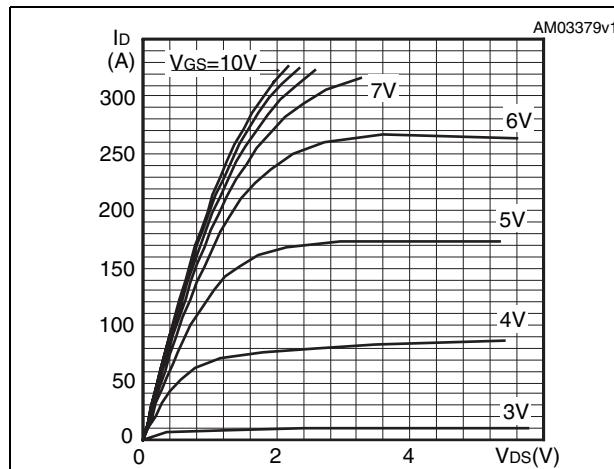


Figure 5. Transfer characteristics

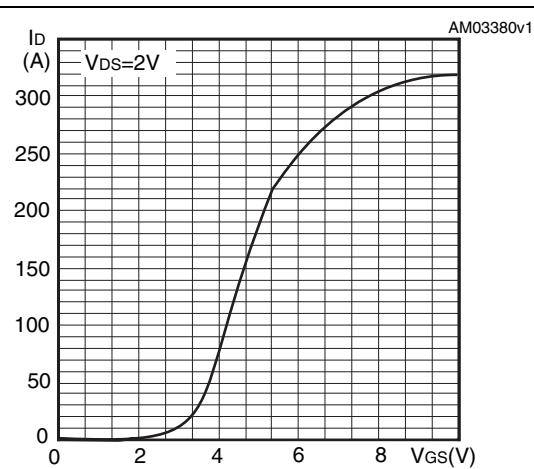
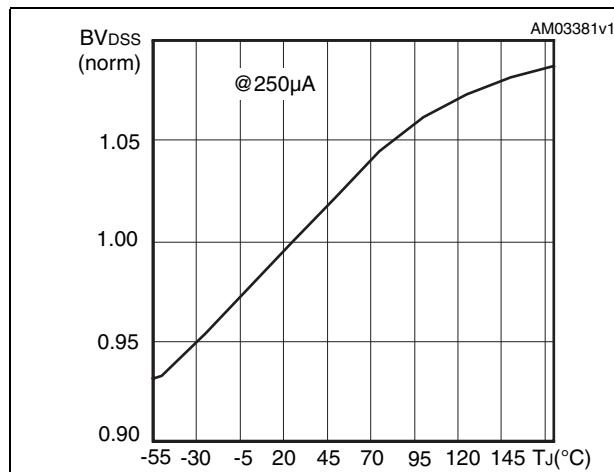
Figure 6. Normalized BV_{DSS} vs temperature

Figure 7. Static drain source on resistance

